

IN THE CLAIMS

Please amend the claims as follows:

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1. (Amended) A method for forming a field emitter device on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter device;
forming a polysilicon cone on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the polysilicon cone are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the polysilicon cone from the gate; and
forming an anode opposing the polysilicon cone.
 2. (Original) The method of claim 1, wherein forming the field emitter device on a substrate includes forming the device on a silicon dioxide (SiO₂) substrate.
 3. (Amended) The method of claim 1, wherein forming the polysilicon cone and the porous oxide layer from a single layer of polysilicon includes masking a cathode region on the substrate a first component of the multiple component mask is used to form the polysilicon cone and the porous oxide layer, and wherein a second component of the multiple component mask is used to form the gate layer.
 4. (Amended) The method of claim 3 1, wherein masking the cathode region forming and utilizing a multiple component mask includes:
forming a oxide-nitride-oxide (ONO) mask over the cathode region;
forming the porous oxide layer;
removing the top oxide from the ONO mask;
etching the nitride to reduce the width of the mask; and
forming the gate layer on the porous oxide and the mask.

5. (Amended) The method of claim 3 1, wherein ~~masking the cathode region forming and utilizing a multiple component mask includes:~~

forming an oxide layer over the cathode region;

forming a first nitride layer over the oxide layer in order to form a structure which reflects the final pattern of the gate layer;

forming a second nitride layer over the first nitride layer and the single polysilicon layer;

etching the second nitride layer, leaving the second nitride layer only on the sidewalls of the structure; and

forming the porous oxide layer;

removing the first and second nitride layers; and

forming the gate layer on the porous oxide and the oxide layer.

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6. (Original) The method of claim 5, wherein forming the porous oxide layer includes:

performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and

oxidizing the porous polysilicon.

7. (Original) The method of claim 1, wherein forming a polysilicon cone includes forming a metal silicide on the polysilicon cone.

8. (Original) The method of claim 7, wherein forming a metal silicide on the polysilicon cone includes using a electron beam to deposit molybdenum (Mo) on the polysilicon cone.

9. (Original) The method of claim 1, wherein forming a gate on the porous oxide layer includes forming a refractory metal gate.

10. (Original) The method of claim 1, wherein isolating the polysilicon cone from the gate includes:

shaping the gate material in close proximity to a top surface of the polysilicon cone using a lift-off technique; and

removing the porous oxide layer adjacent to the polysilicon cone.

11. (Original) The method of claim 1, wherein forming the porous oxide layer includes:
performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and
oxidizing the porous polysilicon.
12. (Amended) A field emitter device on a substrate, comprising:
a cathode formed in a cathode region of the substrate;
a gate insulator formed in an insulator region of the substrate;
a gate formed on the gate insulator; and
an anode opposing the cathode, the field emitter device formed by a method comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter device;
forming a polysilicon cone on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the polysilicon cone are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the polysilicon cone from the gate; and
forming an anode opposing the cathode.
13. (Amended) The field emitter device of claim 12, wherein forming the polysilicon cone and the porous oxide layer from a single layer of polysilicon includes masking a cathode region on the substrate a first component of the multiple component mask is used to form the polysilicon cone and the porous oxide layer, and wherein a second component of the multiple component mask is used to form the gate layer.
14. (Amended) The field emitter device of claim 13 12, wherein masking the cathode region forming and utilizing a multiple component mask includes:
forming a oxide-nitride-oxide (ONO) mask over the cathode region;
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forming the porous oxide layer;
removing the top oxide from the ONO mask;
etching the nitride to reduce the width of the mask; and
forming the gate layer on the porous oxide and the mask.

15. (Amended) The field emitter device of claim 12, wherein ~~masking the cathode region forming and utilizing a multiple component mask~~ includes:

forming an oxide layer over the cathode region;
forming a first nitride layer over the oxide layer in order to form a structure which reflects the final pattern of the gate layer;
forming a second nitride layer over the first nitride layer and the single polysilicon layer;
etching the second nitride layer, leaving the second nitride layer only on the sidewalls of the structure; and
forming the porous oxide layer;
removing the first and second nitride layers; and
forming the gate layer on the porous oxide and the oxide layer.

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16. (Amended) A method for forming a field emitter device on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter device;

forming a cathode on the substrate;
forming a gate insulator layer on the substrate, wherein the gate insulator layer and the cathode are formed from a single layer of polysilicon;
forming a gate layer on the gate insulator layer;
isolating the cathode from the gate; and
forming an anode opposing the cathode.

17. (Original) The method of claim 16, wherein forming the field emitter device on a substrate includes forming the device on a silicon dioxide (SiO₂) substrate.

18. (Original) The method of claim 16, wherein forming a polysilicon cone includes forming a metal silicide on the polysilicon cone.

19. (Amended) The method of claim 16, wherein forming ~~a gate~~ the gate layer on the ~~porous~~ oxide gate insulator layer includes forming a refractory metal gate layer.

20. (Amended) A method of forming a field emitter array on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the
multiple component mask are used to form selected elements of the field emitter array;
forming a number of cathodes on the substrate;
forming a gate insulator layer on the substrate, wherein the gate insulator layer and the number of cathodes are formed from a single layer of polysilicon;
forming a gate layer on the gate insulator layer;
isolating the number of cathodes from the gate; and
forming a number of anodes opposing the number of cathodes.

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21. (Original) The method of claim 20, wherein forming the field emitter array on a substrate includes forming the array on a silicon dioxide (SiO₂) substrate.

22. (Original) The method of claim 20, wherein forming the gate insulator layer includes forming a porous oxide layer.

23.. (Amended) A method of forming a flat panel display, comprising:
forming a field emitter array on a substrate, including:
forming and utilizing a multiple component mask, wherein separate components
of the multiple component mask are used to form selected elements of the field emitter array;
forming a number of cathodes on the substrate;
forming a gate insulator layer on the substrate, wherein the gate insulator layer and the number of cathodes are formed from a single layer of polysilicon;
forming a gate layer on the gate insulator layer;

isolating the number of cathodes from the gate;
forming a number of anodes opposing the number of cathodes;
coupling a row decoder and a column decoder to the field emitter array; and
coupling a processor to the row and column decoders.

24. (Original) The method of claim 23, wherein forming the field emitter array on a substrate includes forming the array on a silicon dioxide (SiO₂) substrate.

25. (Original) The method of claim 23, wherein forming a number of cathodes on the substrate includes forming a number of polysilicon cones on the substrate.

26. (Amended) A method for forming a field emitter array on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;
forming a number of polysilicon cones on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the number of polysilicon cones are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the number of polysilicon cones from the gate; and
forming a number of anodes opposing the number of polysilicon cones.

27. (Original) The method of claim 26, wherein forming the porous oxide layer includes:
performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and
oxidizing the porous polysilicon.

28. (Amended) The method of claim 26, wherein forming a polysilicon cone number of polysilicon cones includes forming a metal silicide on the polysilicon cone number of polysilicon cones.

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29. (Amended) A method of forming a flat panel display, comprising:
forming a field emitter array on a substrate, including:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;
forming a number of polysilicon cones on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the number of polysilicon cones are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the number of polysilicon cones from the gate;
forming a number of anodes opposing the number of polysilicon cones;
coupling a row decoder and a column decoder to the field emitter array; and
coupling a processor to the row and column decoders.
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30. (Original) The method of claim 29, wherein forming the porous oxide layer includes:
performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and
oxidizing the porous polysilicon.
31. (Original) The method of claim 29, wherein forming a gate on the porous oxide layer includes forming a refractory metal gate.
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